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The random failure rate

Keywords

reliability, random failure rate, semi-Markov process

Abstract

A failure rate of the object is assumed to be a stochastic process with nonnegative, right continuous trajectories. A reliability function is defined as an expectation of a function of a random failure rate process. The properties and examples of the reliability function with the random failure rate are presented in the paper. A semi-Markov process as the random failure rate is considered in this paper.

1. Introduction

Often, the environmental conditions are randomly changeable and they cause a random load of an object. Thus, the failure rate depending on the random load is a random process. The reliability function with semi-Markov failure rate was considered in the following papers Kopociński & Kopocińska [5], [6], Grabski [3], [4].

2. Reliability function with random failure rate

Let $\{\lambda(t) : t \geq 0\}$ be a random failure rate of an object. We assume that the stochastic process has the nonnegative, right continuous trajectories. The reliability function is defined as

$$R(t) = E \left[\exp \left(- \int_0^t \lambda(x) dx \right) \right], \quad t \geq 0. \quad (1)$$

It means that the reliability function is an expectation of the process $\{\alpha(t) : t \geq 0\}$, where

$$\alpha(t) = \exp \left(- \int_0^t \lambda(x) dx \right), \quad t \geq 0. \quad (2)$$

Let

$$\overset{g}{R}(t) = \exp \left(- \int_0^t E[\lambda(x)] dx \right), \quad t \geq 0. \quad (3)$$

From Jensen's inequality we get very important result

$$\begin{aligned} R(t) &= E \left[\exp \left(- \int_0^t \lambda(x) dx \right) \right] \\ &\geq \exp \left(- \int_0^t E[\lambda(x)] dx \right) = \overset{g}{R}(t), \quad t \geq 0. \end{aligned} \quad (4)$$

The above mentioned inequality means that the reliability function defined by the stochastic process $\{\lambda(t) : t \geq 0\}$ is greater than or equal to the reliability function with the deterministic failure rate, equal to the expectation $\bar{\lambda}(t) = E[\lambda(t)]$.

It is obvious, that for the stationary stochastic process $\{\lambda(t) : t \geq 0\}$, that has a constant mean value $\bar{\lambda}(t) = E[\lambda(t)] = \lambda$, the reliability function defined by (3) is

$$\overset{g}{R}(t) = \exp \left(- \lambda \int_0^t dx \right) = \exp(-\lambda t), \quad t \geq 0. \quad (5)$$

Hence, we come to conclusion: for each stationary random failure rate process, the according reliability function for each $t \geq 0$, has values greater than or equal to the exponential reliability function with parameter λ .

Example 1.

Suppose that, the failure rate of an object is a stochastic process $\{\lambda(t):t \geq 0\}$, given by $\lambda(t) = Ct, t \geq 0$, where C is a nonnegative random variable. Trajectories of the process $\{o(t):t \geq 0\}$, are

$$\xi(t) = \exp(-c \frac{t^2}{2}), t \geq 0,$$

where c is a value of the random variable C . Assume that the random variable C has the exponential distribution with parameter β :

$$P(C \leq u) = 1 - e^{-\beta u}, u \geq 0.$$

Then, according to (1), we compute the reliability function

$$\begin{aligned} R(t) &= E \left[\exp \left(- \int_0^t Cx dx \right) \right] = \int_0^\infty e^{-\frac{t^2}{2}} \beta e^{-\beta u} du \\ &= \beta \int_0^\infty e^{-u \left(\frac{t^2}{2} + \beta \right)} du = \frac{2\beta}{t^2 + 2\beta} \end{aligned}$$

Figure 1 shows that function.

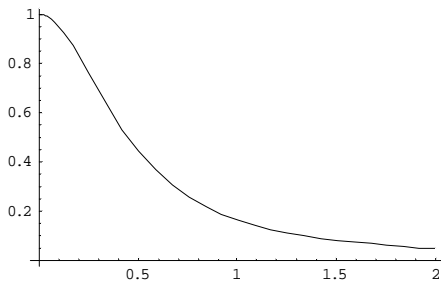


Figure 1. Reliability function $R(t)$

In that case the function (3) is

$$\overset{9}{R}(t) = \exp \left(- \int_0^t E[Cx] dx \right) = \exp \left(- \frac{t^2}{2\beta} \right), t \geq 0.$$

Figure 2 shows that function.

Suppose that a failure rate process $\{\lambda(t):t \geq 0\}$ is a linear function of a random load process $\{u(t):t \geq 0\}$:

$$\lambda(t) = \varepsilon u(t).$$

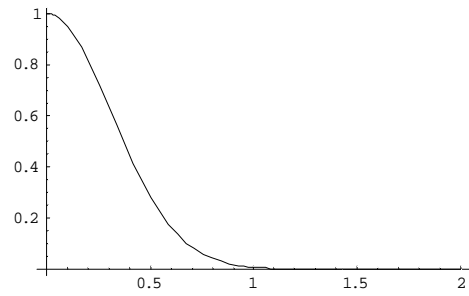


Figure 2. Reliability function $\overset{7}{R}(t)$

Assume that the process $\{u(t):t \geq 0\}$ has an ergodic mean, i.e.

$$\lim_{T \rightarrow \infty} \frac{1}{T} \int_0^T u(x) dx = E[u(t)] = \bar{u}.$$

Then, [2], [3]

$$\lim_{\varepsilon \rightarrow 0} R\left(\frac{t}{\varepsilon}\right) = \exp[-\bar{u}t].$$

It means, that for small ε

$$R(x) \approx \exp[-\varepsilon \bar{u}x].$$

3. Semi-Markov process as a random failure rate

The semi-Markov process as a failure rate and the reliability function with that failure rate was introduced by Kopociński & Kopocińska [5]. Some extensions and developments of the results from [3] were obtained by Grabski [3], [4].

3.1. Semi-Markov processes with a discrete state space

The semi-Markov processes were introduced independently and almost simultaneously by P. Levy, W.L. Smith, and L.Takacs in 1954-55. The essential developments of semi-Markov processes theory were achieved by Cinlar [1], Koroluk & Turbin [8], Limnios & Oprisan [7], Silvestrov [9]. We will apply only semi-Markov processes with a finite or countable state space. The semi-Markov processes are connected to the Markov renewal processes.

Let S be a discrete (finite or countable) state space and let $R_+ = [0, \infty)$, $N_0 = \{0,1,2,\dots\}$. Suppose, that $\xi_n, \vartheta_n, n = 0,1,2,\dots$ are the random variables defined on a joint probabilistic space (Ω, F, P) with values on S and R_+ respectively. A two-dimensional random sequence $\{(\xi_n, \vartheta_n), n = 0,1,2,\dots\}$ is called a Markov renewal chain if for all $i_0, \dots, i_{n-1}, i \in S, t_0, \dots, t_n \in R_+, n \in N_0$.

The equalities

$$1. P\{\xi_{n+1} = j, \vartheta_{n+1} \leq t | \xi_n = i, \vartheta_n = t_n, \dots, \xi_0 = i_0, \vartheta_0 = t_0\} \\ = P\{\xi_{n+1} = j, \vartheta_{n+1} \leq t | \xi_n = i\} = Q_{ij}(t) \quad (6)$$

$$2. P\{\xi_0 = i_0, \vartheta_0 = 0\} = P\{\xi_0 = i_0\} = p_{i_0} \quad (7)$$

hold.

It follows from the above definition that a Markov renewal chain is a homogeneous two-dimensional Markov chain such that the transition probabilities do not depend on the second component. It is easy to notice that a random sequence $\{\xi_n : n = 0, 1, 2, \dots\}$ is a homogeneous one-dimensional Markov chain with the transition probabilities

$$p_{ij} = P\{\xi_{n+1} = j | \xi_n = i\} = \lim_{t \rightarrow \infty} Q_{ij}(t). \quad (8)$$

A matrix

$$Q(t) = [Q_{ij}(t) : i, j \in S]$$

is called a Markov renewal kernel. The Markov renewal kernel and the initial distribution $p = [p_i : i \in S]$ define the Markov renewal chain. That chain allows us to construct a semi-Markov process.

Let

$$\tau_0 = \vartheta_0 = 0, \tau_n = \vartheta_1 + \dots + \vartheta_n, \tau_\infty = \sup\{\tau_n : n \in N_0\}$$

A stochastic process $\{X(t) : t \geq 0\}$ given by the following relation

$$X(t) = \xi_n \text{ for } t \in [\tau_n, \tau_{n+1}) \quad (9)$$

is called a semi-Markov process on S generated by the Markov renewal chain related to the kernel $Q(t), t \geq 0$ and the initial distribution p.

Since the trajectory of the semi-Markov process keeps the constant values on the half-intervals $[\tau_n, \tau_{n+1})$ and it is a right-continuous function, from equality $X(\tau_n) = \xi_n$, it follows that the sequence $\{X(\tau_n) : n = 0, 1, 2, \dots\}$ is a Markov chain with the transition probabilities matrix

$$P = [p_{ij} : i, j \in S]. \quad (10)$$

The sequence $\{X(\tau_n) : n = 0, 1, 2, \dots\}$ is called an embedded Markov chain in a semi-Markov process $\{X(t) : t \geq 0\}$.

The function

$$F_{ij}(t) = P\{\tau_{n+1} - \tau_n \leq t | X(\tau_n) = i, X(\tau_{n+1}) = j\} \\ = \frac{Q_{ij}(t)}{p_{ij}} \quad (11)$$

is a cumulative probability distribution of a holding time of a state i , if the next state will be j . From (11) we have

$$Q_{ij}(t) = p_{ij} F_{ij}(t). \quad (12)$$

The function

$$G_i(t) = P\{\tau_{n+1} - \tau_n \leq t | X(\tau_n) = i\} = \sum_{j \in S} Q_{ij}(t) \quad (13)$$

is a cumulative probability distribution of an occupation time of the state i .

A stochastic process $\{N(t) : t \geq 0\}$ defined by

$$N(t) = n \text{ for } t \in [\tau_n, \tau_{n+1}) \quad (14)$$

is called a counting process of the semi-Markov process $\{X(t) : t \geq 0\}$.

The semi-Markov process $\{X(t) : t \geq 0\}$ is said to be regular if for all $t \geq 0$

$$P\{N(t) < \infty\} = 1. \quad (15)$$

It means that the process $\{X(t) : t \geq 0\}$ has the finite number of state changes on a finite period.

Every Markov process $\{X(t) : t \geq 0\}$ with the discrete space S and the right-continuous trajectories keeping constant values on the half-intervals, with the generating matrix of the transition rates $A = [\alpha_{ij} : i, j \in S], 0 < -\alpha_{ii} = \alpha_i < \infty$ is the semi-Markov process with the kernel

$$Q(t) = [Q_{ij}(t) : i, j \in S],$$

where

$$Q_{ij}(t) = p_{ij}(1 - e^{-\alpha_i t}), t \geq 0,$$

$$p_{ij} = \frac{\alpha_{ij}}{\alpha_i} \text{ for } i \neq j$$

and

$$p_{ii} = 0.$$

3.2. Semi-Markov failure rate

Suppose that the random failure rate $\{\lambda(t) : t \geq 0\}$ is the semi-Markov process with the discrete state space $S = \{\lambda_j : j \in J\}$, $J = \{0,1,\dots,m\}$ or $J = \{0,1,2,\dots\}$, $0 \leq \lambda_0 < \lambda_1 < \dots$ with the kernel

$$\mathbf{Q}(t) = [Q_{ij}(t) : i, j \in J]$$

and the initial distribution $p = [p_i : i \in J]$.

We define a conditional reliability function as

$$R_i(t) = E \left[\exp \left(- \int_0^t \lambda(u) du \right) \mid \lambda(0) = \lambda_i \right], \quad t \geq 0, \quad i \in J. \quad (16)$$

In [3] it is proved, that for the regular semi-Markov process $\{\lambda(t) : t \geq 0\}$ the conditional reliability functions $R_i(t), t \geq 0, i \in J$ defined by (16), satisfy the system of equations

$$R_i(t) = e^{-\lambda_i t} [1 - G_i(t)] + \sum_{j=0}^t \int_0^t e^{-\lambda_i x} R_j(t-x) dQ_{ij}(x), \quad (17)$$

$i \in J.$

Using the Laplace transform we obtain the system of linear equations

$$\tilde{R}_i(s) = \frac{1}{s + \lambda_i} - \tilde{G}_i(s + \lambda_i) + \sum_j \tilde{R}_j(s) \tilde{q}_{ij}(s + \lambda_i), \quad i \in J \quad (18)$$

where

$$\tilde{R}_i(s) = \int_0^\infty e^{-st} R_i(t) dt,$$

$$\tilde{G}_i(s) = \int_0^\infty e^{-st} G_i(t) dt,$$

$$\tilde{q}_{ij}(s) = \int_0^\infty e^{-st} dQ_{ij}(t).$$

In matrix notation we have

$$[\mathbf{I} - \tilde{\mathbf{q}}_\lambda(s)] \tilde{\mathbf{R}}(s) = \tilde{\mathbf{H}}(s), \quad (19)$$

where

$$\tilde{\mathbf{R}}(s) = [\tilde{R}_i(s) : i \in J]^T,$$

$$[\mathbf{I} - \tilde{\mathbf{q}}_\lambda(s)] = [\delta_{ij} - \tilde{q}_{ij}(s + \lambda_i) : i, j \in J],$$

$$\tilde{\mathbf{H}}(s) = \left[\frac{1}{s + \lambda_i} - \tilde{G}_i(s + \lambda_i) : i \in J \right].$$

The conditional mean times to failure we obtain from the formula

$$\mu_i = \lim_{p \rightarrow 0^+} \tilde{R}_i(p), \quad p \in (0, \infty), \quad i \in J \quad (20)$$

The unconditional mean time to failure has a form

$$\mu = \sum_{i \in J} P(\lambda(0) = \lambda_i) \mu_i. \quad (21)$$

3.3. 3-state random walk process as a failure rate

Assume that the failure rate is a semi-Markov process $\{\lambda(t) : t \geq 0\}$ with the state space $S = \{\lambda_0, \lambda_1, \lambda_2\}$ and the kernel

$$\mathbf{Q}(t) = \begin{bmatrix} 0 & G_0(t) & 0 \\ aG_1(t) & 0 & (1-a)G_1(t) \\ 0 & G_2(t) & 0 \end{bmatrix},$$

where $G_0(t), G_1(t), G_2(t)$ are the cumulative probability distribution functions with nonnegative support. Suppose that at least one of the functions is absolutely continuous with respect to the Lebesgue measure. Let $p = [p_0, p_1, p_2]$ be an initial probability distribution of the process. That stochastic process is called the 3-state random walk process. In that case the matrices from the equation (19) are

$$[\mathbf{I} - \tilde{\mathbf{q}}_\lambda(s)] =$$

$$= \begin{bmatrix} 1 & -\tilde{g}_0(s + \lambda_0) & 0 \\ -a\tilde{g}_1(s + \lambda_1) & 1 & -(1-a)\tilde{g}_1(s + \lambda_1) \\ 0 & -\tilde{g}_2(s + \lambda_2) & 1 \end{bmatrix}, \quad (22)$$

where

$$\tilde{g}_i(s) = \int_0^\infty e^{-st} dG_i(t), \quad i = 0,1,2.$$

$$\tilde{\mathbf{R}}(s) = \begin{bmatrix} \tilde{R}_0(s) \\ \tilde{R}_1(s) \\ \tilde{R}_2(s) \end{bmatrix},$$

$$\tilde{\mathbf{H}}(s) = \begin{bmatrix} \frac{1}{s+\lambda_0} - \tilde{G}_0(s+\lambda_0) \\ \frac{1}{s+\lambda_1} - \tilde{G}_1(s+\lambda_1) \\ \frac{1}{s+\lambda_2} - \tilde{G}_2(s+\lambda_2) \end{bmatrix}. \quad (23)$$

The Laplace transform of unconditional reliability function is

$$\tilde{R}(s) = p_0 \tilde{R}_0(s) + p_1 \tilde{R}_1(s) + p_2 \tilde{R}_2(s)$$

Example 2.
Assume that

$$p_0 = 1, \quad p_1 = 0, \quad p_2 = 0$$

and

$$G_0(t) = 1 - (1 + \alpha t)e^{-\alpha t},$$

$$G_1(t) = 1 - e^{-\beta t},$$

$$G_2(t) = 1 - (1 + \gamma t)e^{-\gamma t}, \quad t \geq 0.$$

The corresponding Laplace transforms are

$$\tilde{G}_0(s) = \frac{\alpha^2}{s(s+\alpha)^2},$$

$$\tilde{G}_1(s) = \frac{\beta}{s(s+\beta)},$$

$$\tilde{G}_2(s) = \frac{\gamma^2}{s(s+\gamma)^2},$$

$$\tilde{g}_0(s) = \frac{\alpha^2}{(s+\alpha)^2},$$

$$\tilde{g}_1(s) = \frac{\beta}{s+\beta},$$

$$\tilde{g}_2(s) = \frac{\gamma^2}{(s+\gamma)^2}.$$

Let

$$p = [1, 0, 0], \quad a = 0.4$$

and

$$\alpha = 0.4, \quad \beta = 0.04, \quad \gamma = 0.02, \quad \lambda_0 = 0, \quad \lambda_1 = 0.1, \quad \lambda_2 = 0.2.$$

Since the matrices (22) and (23) are

$$[\mathbf{I} - \tilde{\mathbf{q}}_\lambda(s)] = \begin{bmatrix} 1 & -\frac{0.0025}{(0.05+s)^2} & 0 \\ -0.4 \frac{0.04}{0.14+s} & 1 & -0.6 \frac{0.04}{0.14+s} \\ 0 & -\frac{0.0004}{(0.22+s)^2} & 1 \end{bmatrix},$$

$$\tilde{\mathbf{H}}(s) = \begin{bmatrix} \frac{1}{s} - \frac{0.0025}{s(0.05+s)^2} \\ \frac{1}{s+0.1} - \frac{0.04}{(s+0.1)(0.14+s)} \\ \frac{1}{s+\lambda_2} - \frac{0.0004}{(s+0.2)(0.22+s)^2} \end{bmatrix}.$$

From solution of equation (19), in this case, we obtain

$$\tilde{R}(s) = \tilde{R}_0(s) = \frac{\tilde{a}(s)}{\tilde{b}(s)}$$

where

$$\tilde{a}(s) = (0.01623 + 0.23349s + s^2)$$

$$\cdot (0.05002 + 0.44655s + s^2)$$

$$\tilde{b}(s) = (0.03083 + s)(0.07486 + s)(0.13292 + s)$$

$$\cdot (0.04882 + 0.44138s + s^2)$$

Using the MATHEMATICA computer program we obtain the reliability function as the inverse Laplace transform

$$\begin{aligned} R(t) = & 0.51646e^{-0.13292t} + 0.23349e^{-0.07486t} \\ & + 2.28565e^{-0.13292t} \\ & - 2 \cdot 0.01539e^{-0.22069t} \cos(0.01075t) \\ & - 2 \cdot 0.01343e^{-0.22069t} \cos(0.01075t). \end{aligned}$$

Figure 3 shows this reliability function.

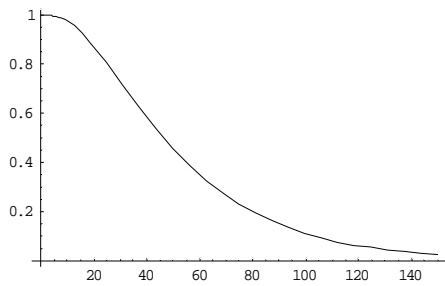


Figure 3. The reliability function from example 2

The corresponding density function is shown in Figure 4.

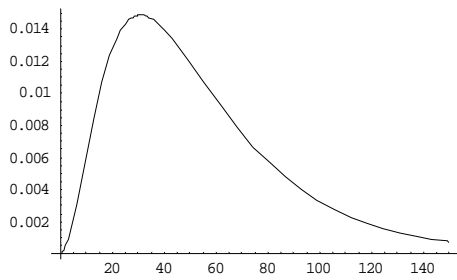


Figure 4. The density function from example 2

3.4. The Poisson process as a failure rate

Suppose that the random failure rate $\{\lambda(t) : t \geq 0\}$ is the Poisson process with parameter $\lambda > 0$. Of course, the Poisson process is the Markov process with the counting state space $S = \{0,1,2,\dots\}$. That process can be treated as the semi-Markov process defined on by the initial distribution $p = [1,0,0,\dots]$ and the kernel

$$Q(t) = \begin{bmatrix} 0 & G_0(t) & 0 & 0 & \dots \\ 0 & 0 & G_1(t) & 0 & \dots \\ 0 & 0 & 0 & G_2(t) & 0 \\ \dots & \dots & \dots & \dots & \dots \\ \dots & \dots & \dots & \dots & \dots \end{bmatrix},$$

where

$$G_i(t) = 1 - e^{-\lambda t}, t \geq 0, i = 0,1,2,\dots$$

The Poisson process is of course a Markov process too.

Applying equation (19), Grabski [3] proved the following theorem:

If the random failure rate $\{\lambda(t) : t \geq 0\}$ is the Poisson process with parameter $\lambda > 0$, then the reliability function defined by (16) takes form

$$R(t) = \exp\{-\lambda [t - 1 + \exp(-t)]\}, t \geq 0.$$

The corresponding density function is given by the formula

$$f(t) = \lambda \exp\{-\lambda [t - 1 + \exp(-t)]\} [1 - \exp(-t)], t \geq 0.$$

Those functions with parameter $\lambda = 0.2$ are shown in Figure 5 and Figure 6.

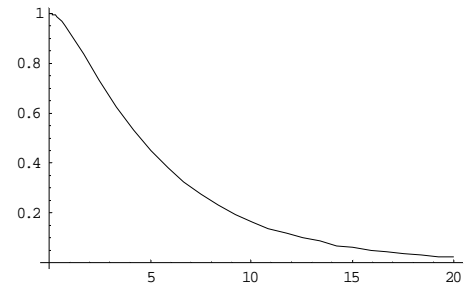


Figure 5. The reliability function for the Poisson process

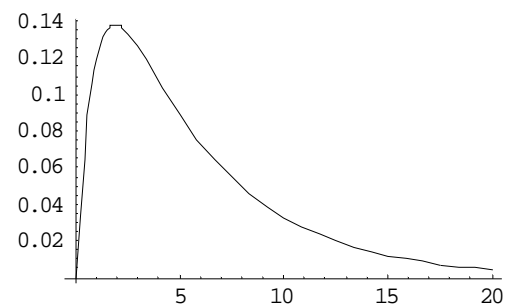


Figure 6. The density function for the Poisson process

3.5. The Furry-Yule process as a failure rate

The Furry-Yule is the semi-Markov process on the counting state space $S = \{0,1,2,\dots\}$ with the initial distribution $p = [1,0,0,\dots]$ and the kernel similar to the Poisson process

$$Q(t) = \begin{bmatrix} 0 & G_0(t) & 0 & 0 & \dots \\ 0 & 0 & G_1(t) & 0 & \dots \\ 0 & 0 & 0 & G_2(t) & 0 \\ \dots & \dots & \dots & \dots & \dots \\ \dots & \dots & \dots & \dots & \dots \end{bmatrix},$$

where

$$G_i(t) = 1 - e^{-\lambda(i+1)t}, t \geq 0, i = 0,1,2,\dots$$

The Furry-Yule process is also the Markov process. Assume that the random failure rate $\{\lambda(t) : t \geq 0\}$ is the Furry-Yule process with parameter $\lambda > 0$. The following theorem is proved by Grabski [4]:
If the random failure rate $\{\lambda(t) : t \geq 0\}$ is the Furry-Yule process with parameter $\lambda > 0$, then the reliability function defined by (1) is given by

$$R(t) = \frac{(\lambda + 1) \exp(-\lambda t)}{1 + \lambda \exp[-(\lambda + 1)t]}, t \geq 0.$$

The corresponding density function is

$$f(t) = \frac{\lambda(\lambda + 1) \exp[1 - (\lambda + 1)t]}{\{1 + \lambda \exp[-(\lambda + 1)t]\}^2}, t \geq 0.$$

Those functions with parameter $\lambda = 0.2$ are shown in *Figure 7* and *Figure 8*.

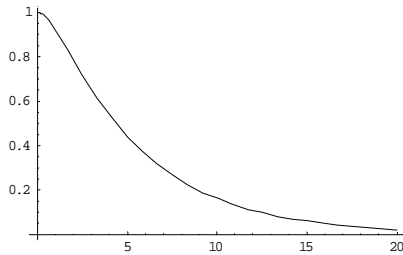


Figure 7. The reliability function for the Furry-Yule process

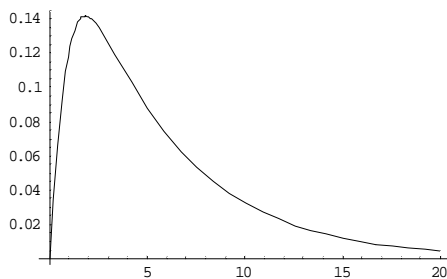


Figure 8. The density function for the Furry-Yule process

4. Conclusion

Frequently, because of the randomly changeable environmental conditions and tasks, the assumption that a failure rate of an object is a random process seems to be proper and natural. We obtain the new interesting classes of reliability functions for the different stochastic failure rate processes.

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